## Search Notes



Appli	cation/Control No.	Applicant(s)/Patent Under Reexamination
10747	7741	UENO ET AL.
Exam	iner	Art Unit
LUON	IG T NGUYEN	2622

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST (USPAT; USPGPUB; JPO; EPO; DERWENT; IBM_TDB) see search history	6/05/08	LTN		
348/300,302,308 (text search)	12/24/08	LTN		
EAST (USPAT; USPGPUB; JPO; EPO; DERWENT; IBM_TDB) see search history	12/24/08	LTN		
Updated East using previously cited references	11/07/09	LTN		
EAST (USPAT; USPGPUB; JPO; EPO; DERWENT; IBM_TDB) see search history	05/24/10	LTN		
EAST (USPAT; USPGPUB; JPO; EPO; DERWENT; IBM_TDB) see search history	05/06/11	LTN		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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